Device Modeling Report

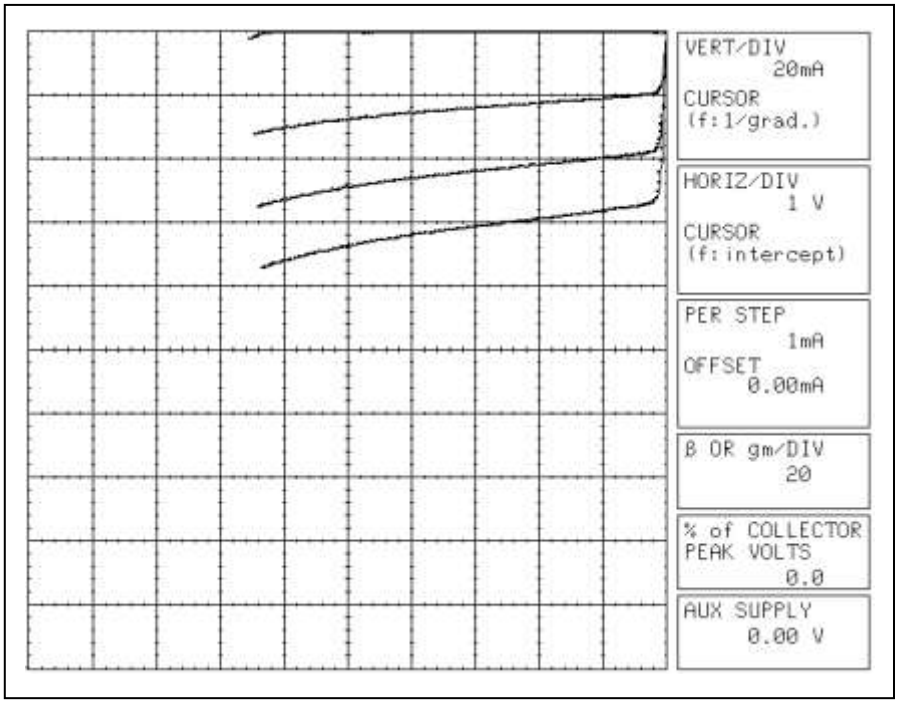
COMPONENTS:BIPOLAR JUNCTION TRANSISTOR
PART NUMBER:2SC3112
MANUFACTURER:TOSHIBA

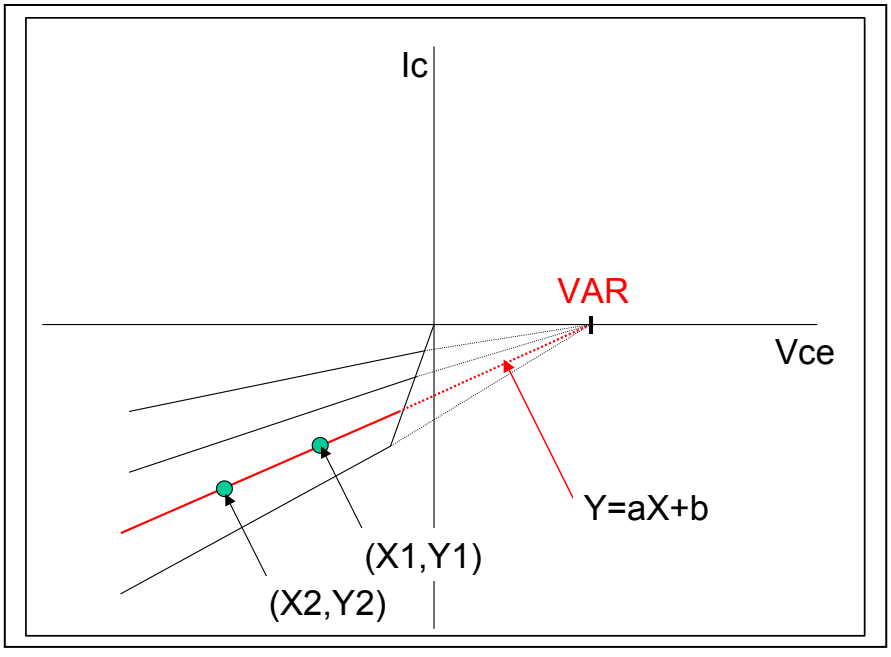
Bee Technologies Inc.

Pspice model parameter	Model description
IS	Saturation Current
BF	Ideal Maximum Forward Beta
NF	Forward Current Emission Coefficient
VAF	Forward Early Voltage
IKF	Forward Beta Roll-off Knee Current
ISE	Non-ideal Base-Emitter Diode Saturation Current
NE	Non-ideal Base-Emitter Diode Emission Coefficient
BR	Ideal Maximum Reverse Beta
NR	Reverse Emission Coefficient
VAR	Reverse Early Voltage
IKR	Reverse Beta Roll-off Knee Current
ISC	Non-ideal Base-Collector Diode Saturation Current
NC	Non-ideal Base-Collector Diode Emission Coefficient
NK	Forward Beta Roll-off Slope Exponent
RE	Emitter Resistance
RB	Base Resistance
RC	Series Collector Resistance
CJE	Zero-bias Emitter-Base Junction Capacitance
VJE	Emitter-Base Junction Potential
MJE	Emitter-Base Junction Grading Coefficient
CJC	Zero-bias Collector-Base Junction Capacitance
VJC	Collector-base Junction Potential
MJC	Collector-base Junction Grading Coefficient
FC	Coefficient for Onset of Forward-bias Depletion Capacitance
TF	Forward Transit Time
XTF	Coefficient for TF Dependency on Vce
VTF	Voltage for TF Dependency on Vce
ITF	Current for TF Dependency on Ic
PTF	Excess Phase at f=1/2pi*TF
TR	Reverse Transit Time
EG	Activation Energy
XTB	Forward Beta Temperature Coefficient
XTI	Temperature Coefficient for IS

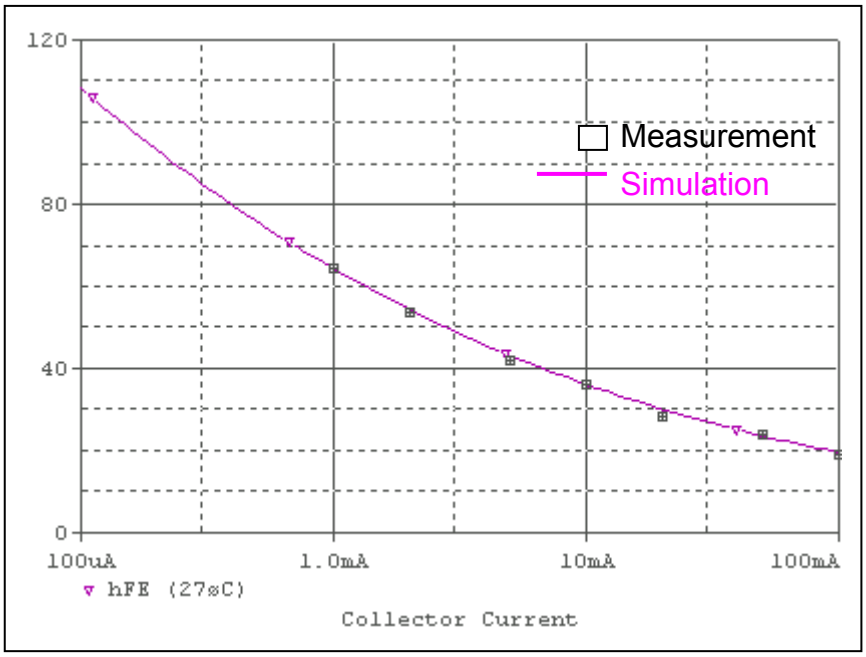
Reverse

Reverse Early Voltage Characteristic



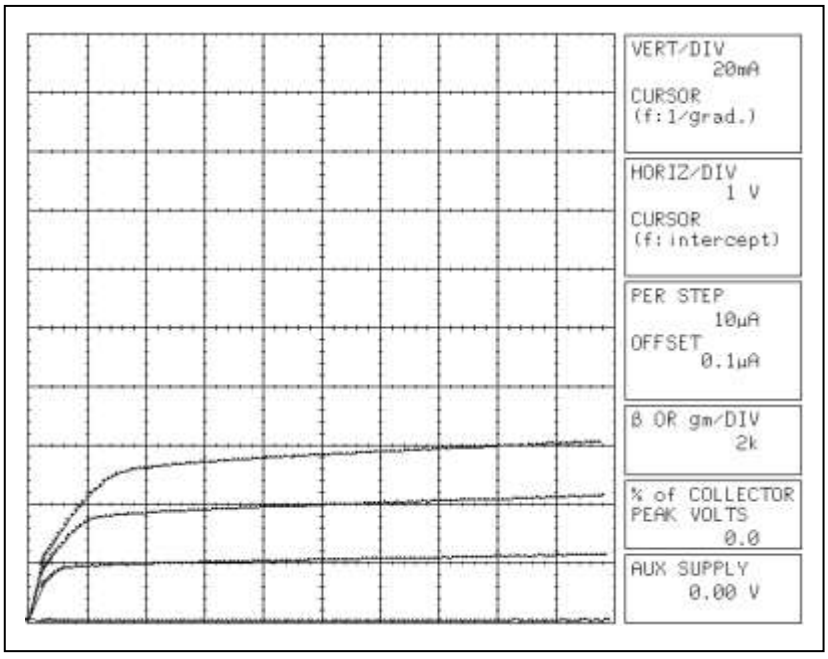


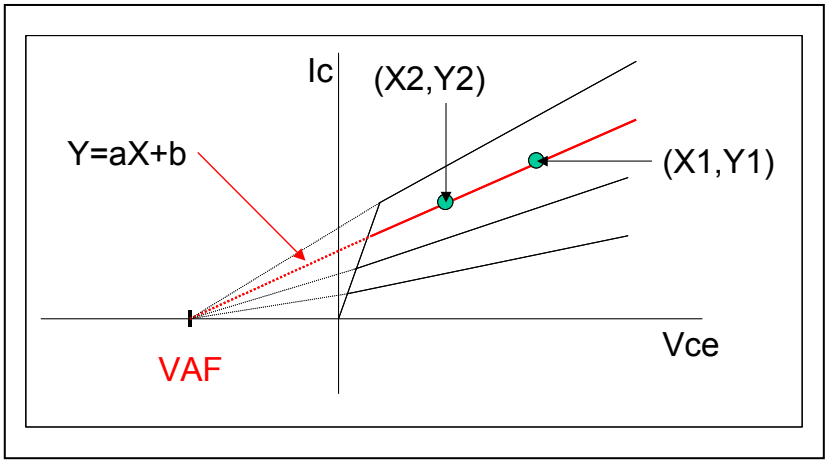
Reverse DC Beta Characteristic (Ie vs. h_{FE})



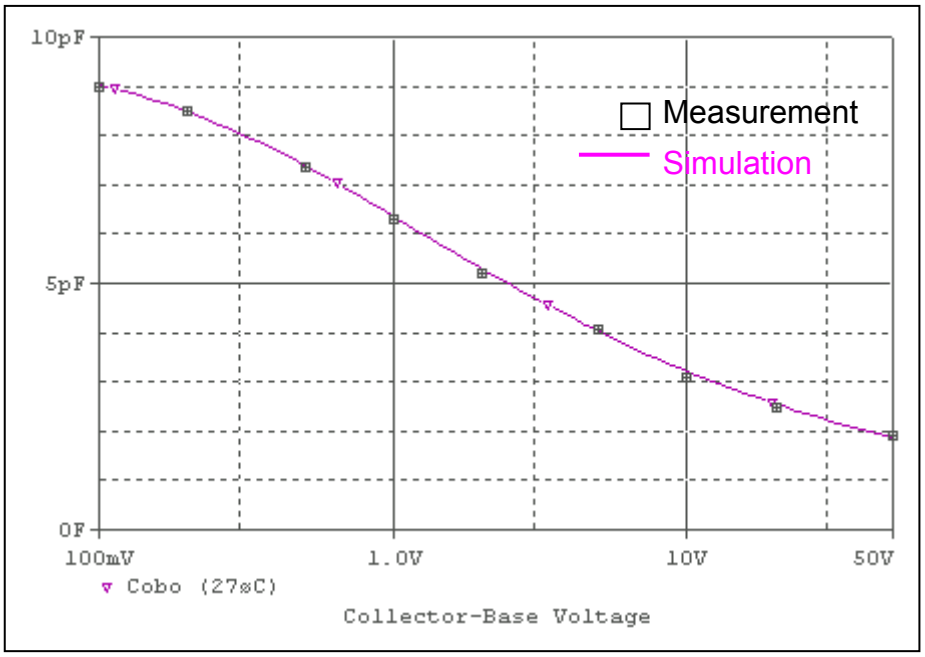
Forward

Forward Early Voltage Characteristic

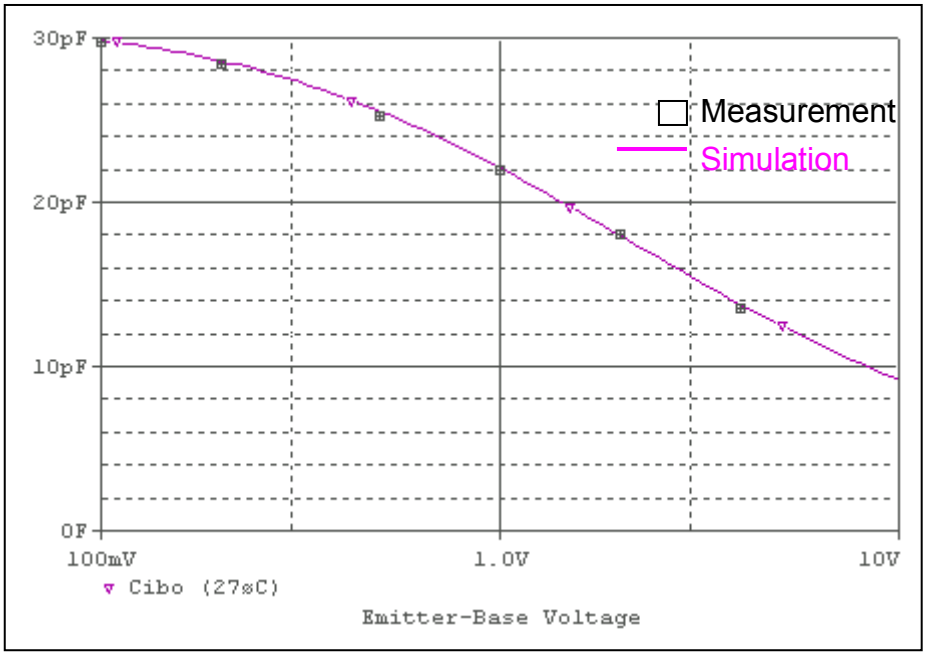




C-B Capacitance Characteristic

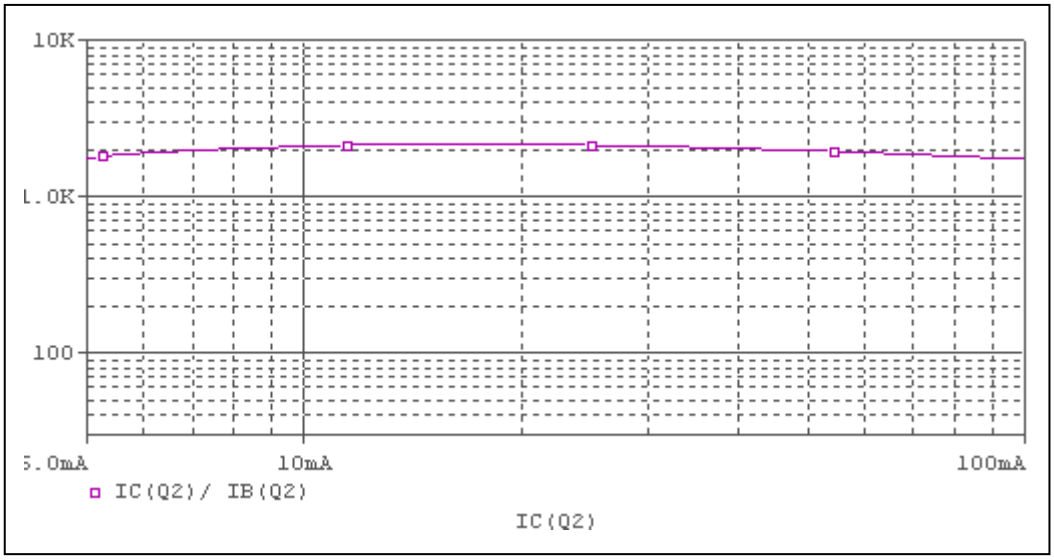


E-B Capacitance Characteristic

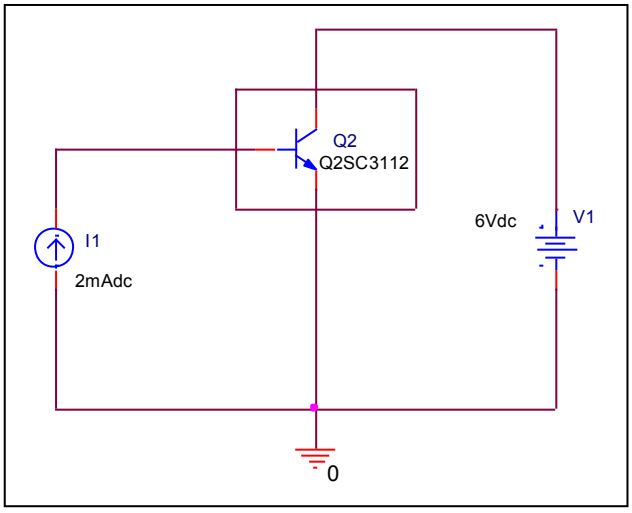


BJT Ic-hFE characteristics

Circuit simulation result

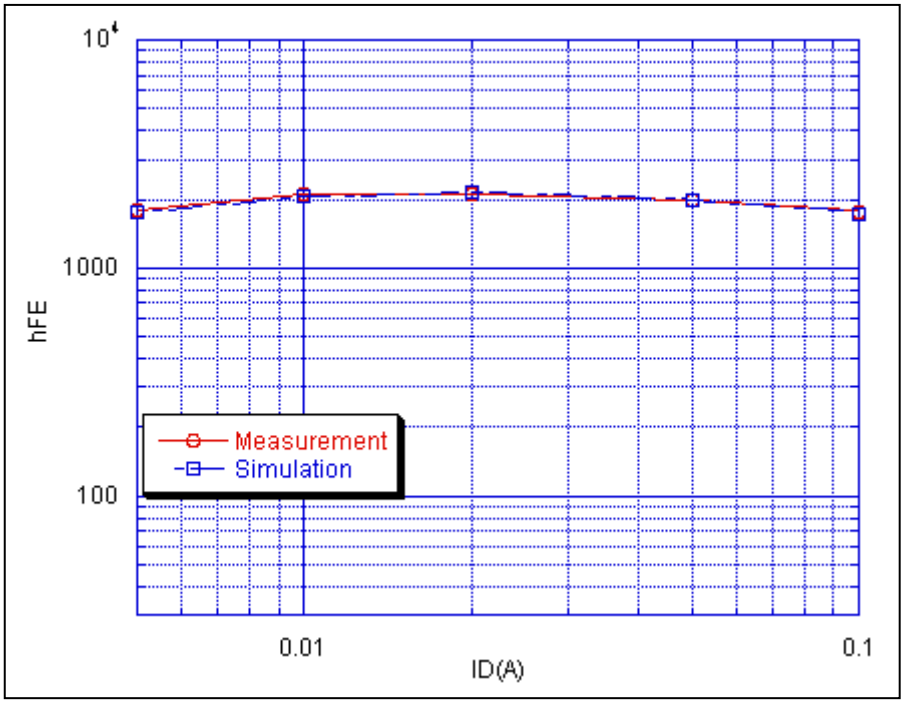


Evaluation circuit



Comparison Graph

Circuit simulation result

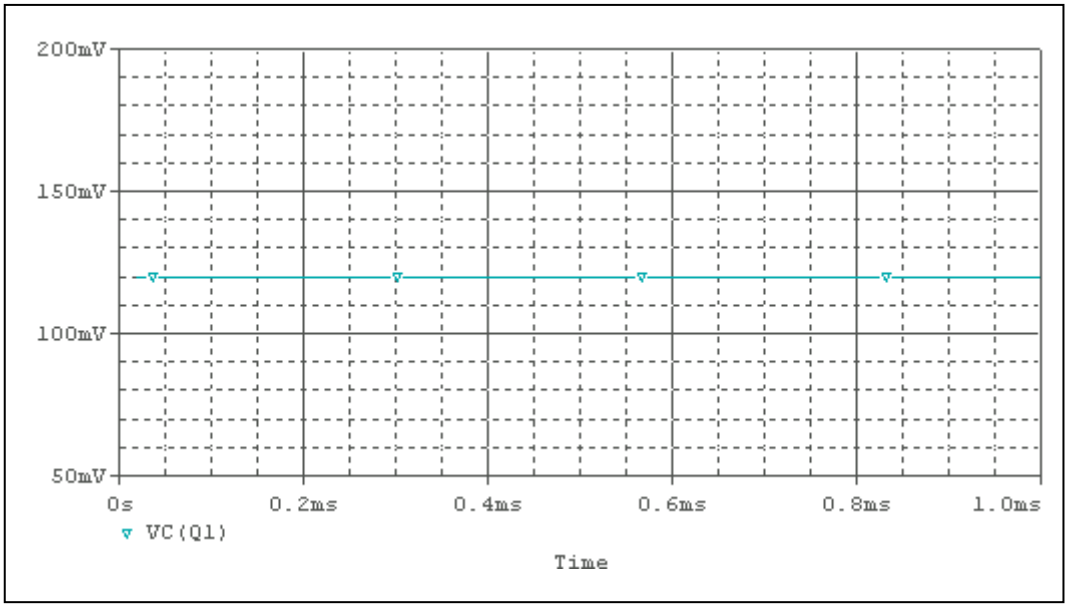


Simulation result

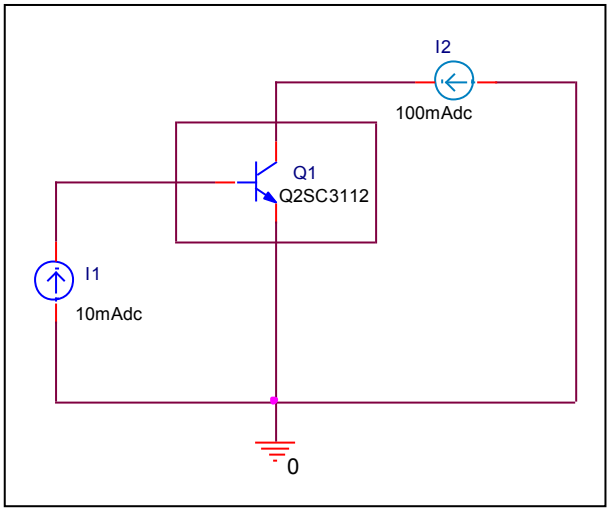
Ic(A)	hFE		%Error
	Measurement	Simulation	
0.005	1800	1768	1.777777778
0.01	2127	2085	1.97461213
0.02	2105	2148	2.042755344
0.05	1968	1963	0.254065041
0.1	1742	1734	0.45924225

BJT Vce(sat) voltage Characteristics

Circuit simulation result



Evaluation circuit



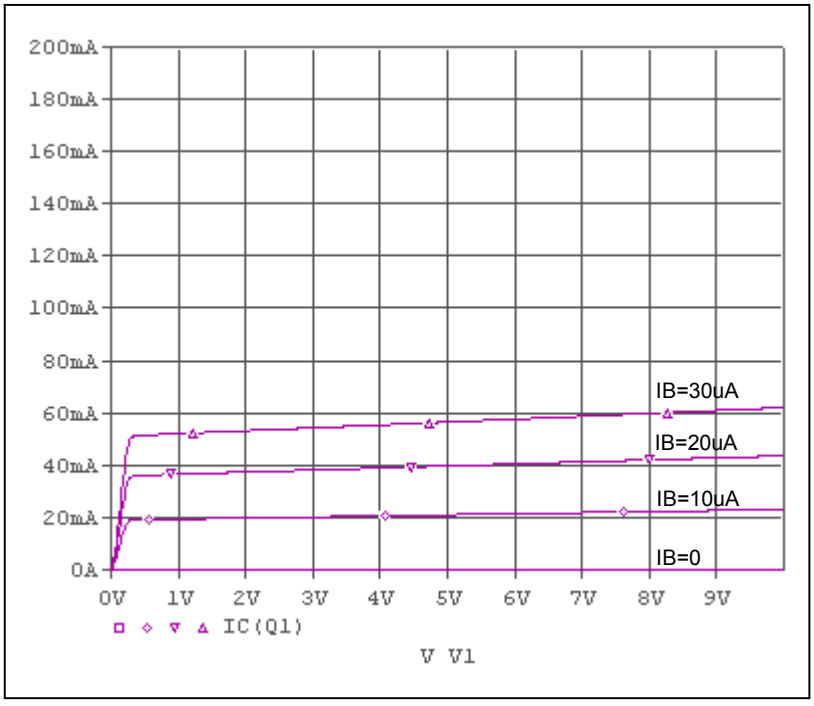
Simulation result

Test condition: IC/IB = 10, IC=100mA

Vce(sat)(V)		
Measurement	**Simulation**	**Error(%)**
120m[max]	**119.43m**	**0.475**

Output Characteristics

Circuit simulation result



Evaluation circuit